NN514260 / NN514260A series
Fast Page Mode CMOS 256K × 16bit Dynamic

NPNX

DESCRIPTION

The NN514260/A series is a high performance CMOS Dynamic Random Access Memory organized as 262,144 words by 16 bits. The NN514260/A series is fabricated with advanced CMOS technology and designed with innovative design techniques resulting in high speed, extremely low power and wide operating margins at both component and system levels.

The NN514260/A series features a high speed page mode operation in which a high speed read, write or read-write is performed on any column address along a row address.

An extremely short row address capture time and an asynchronous column address decoder relax the timing constraints associated with address multiplexing.

The outputs are tri-stated by $\overline{CAS}$ which, in essence, acts as an output enable independent of $\overline{RAS}$ with very fast $\overline{CAS}$ to output access time.

Refresh is accomplished by performing $\overline{RAS}$ only refresh cycles, hidden refresh cycles, $\overline{CAS}$ before $\overline{RAS}$ refresh cycles, or normal read or write cycles on the 512 address combinations of A0 to A8 during a 8 ms period.

Multiplexed address inputs permit The NN514260/A series to be packaged in a standard 40-pin plastic SOJ,44-pin plastic TSOP TYPEII. The package sizes provide high system bit densities and are compatible with widely available automated testing and insertion equipment. System level features include single power supply of 5V ±10% tolerance and direct interface with high performance TTL logic families.

FEATURES

- 262,144 × 16 bit Organization
- Single 5V ±10% Power Supply
- Performance Ranges

(NN514260)

Parameter	-45	-50	-60	-70
Max. $\overline{RAS}$ Access Time (t_{RAC})	45ns	50ns	60ns	70ns
Max. $\overline{CAS}$ Access Time (t_{CAC})	15ns	15ns	15ns	20ns
Max. Column Address Access Time (t_{AA})	25ns	27ns	30ns	35ns
Min. Read/Write Cycle Time (t_{RC})	80ns	90ns	110ns	130ns

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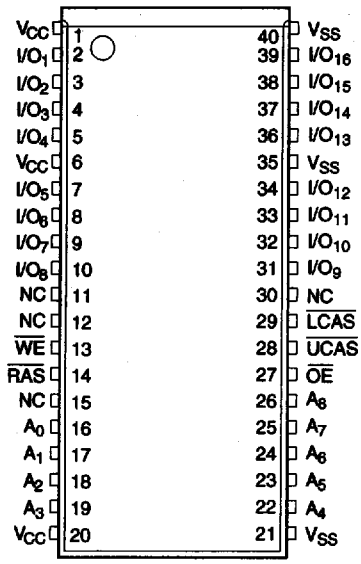
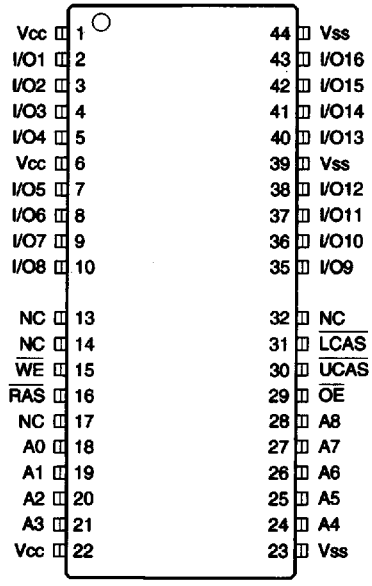
Parameter	-35	-40	-45	-50	-60
Max. $\overline{RAS}$ Access Time (t_{RAC})	35ns	40ns	45ns	50ns	60ns
Max. $\overline{CAS}$ Access Time (t_{CAC})	10ns	12ns	13ns	13ns	15ns
Max. Column Address Access Time (t_{AA})	17ns	20ns	25ns	25ns	30ns
Min. Read/Write Cycle Time (t_{RC})	60ns	70ns	80ns	90ns	110ns

- Fast Page Mode Operation
- Separate $\overline{CAS}$ ($\overline{UCAS}$, $\overline{LCAS}$) for Byte Selection
- Byte Read/Write Mode Operation
- Low Power Operation
  Low Standby Current (CMOS level inputs)
  – Standard 1mA
  – L version 100µA
- 512 Refresh Cycles
  – Standard distributed across 8ms
  – L version distributed across 128ms
- Self Refresh Mode
  (L version)
- All inputs/Outputs and Clocks fully TTL and CMOS compatible
- Refresh Modes
  $\overline{RAS}$ only
  $\overline{CAS}$ before $\overline{RAS}$
  Hidden Refresh
- High Reliability Package
  Plastic 40pin SOJ (P40SJ-2B)
  Plastic 44pin TSOP TYPEII (P44/40TP-3B)
  (P44/40TP-3B-L)*
  *Note: Only for NN514260A

PIN CONFIGURATION (TOP VIEW)



40-pin SOJ (400mil)
P40SJ-2B



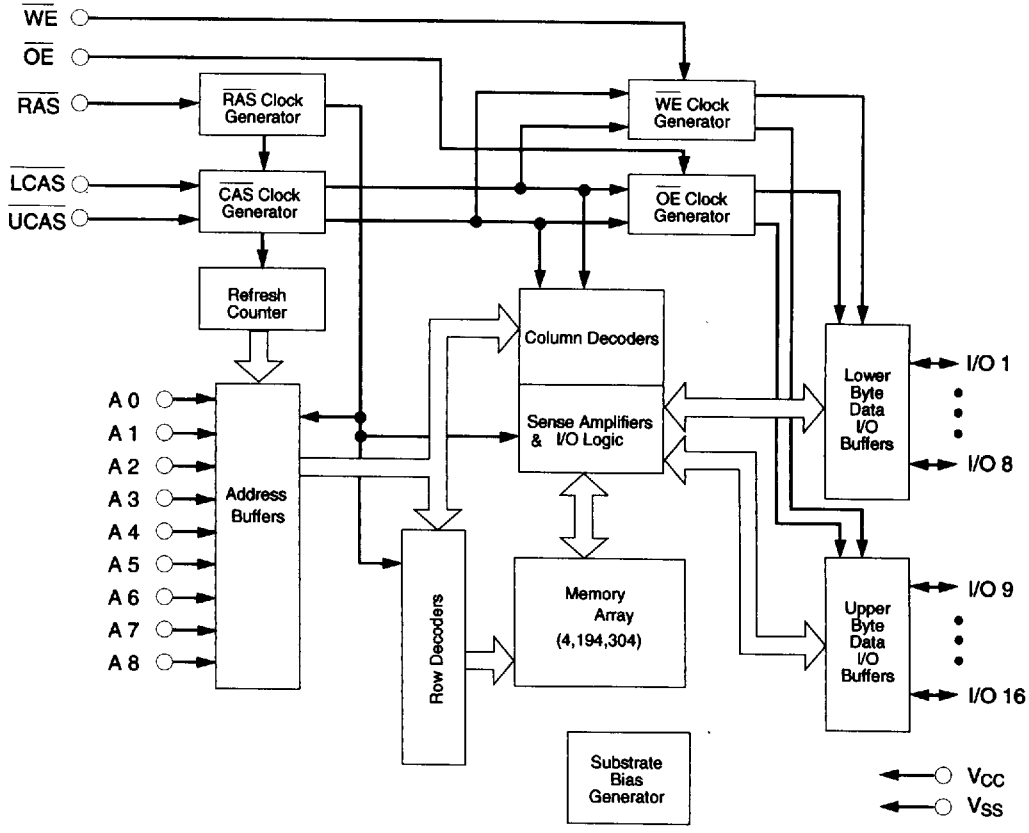
44/40-pin TSOP TYPE (II)
(400mil)
P44/40TP-3B
P44/40TP-3B-L*

*Note: Only for NN514260A

PIN NAMES

A0~A8	Address Inputs
$\overline{RAS}$	Row Address Strobe
$\overline{UCAS}$	Column Address Strobe Upper Byte Control
$\overline{LCAS}$	Column Address Strobe Lower Byte Control
$\overline{OE}$	Output Enable
I/O1~I/O16	Data-in / Data-out
$\overline{WE}$	Write Enable
V_{CC}	+5V Supply
V_{SS}	Ground
NC	No Connection

FUNCTIONAL BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

RATING	SYMBOL	VALUE	UNIT
Voltage on Any Pin Relative to V_{SS}	Vin,Vout	−1 to 7	V
Voltage on Vcc Relative to V_{SS}	V_{CC}	−1 to 7	V
Storage Temperature (Plastic)	Tstg	−55 to +125	°C
Power Dissipation	Pd	1.0	W
Ambient Operating Temperature	Ta	0 to + 70	°C
Short Circuit Output Current	Iout	50	mA

Permanent device damage can occur if absolute maximum ratings are exceeded. Functional operation should be restricted to the conditions as detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods can affect device reliability.

DC OPERATING CONDITIONS

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
V_{CC}	Supply Voltage	4.5	5.0	5.5	V
V_{SS}	Supply Voltage	0	0	0	V
V_{IH}	Input High Voltage, All Inputs	2.4	—	6.5	V
V_{IL}	Input Low Voltage, All Inputs	−0.5	—	0.8	V

Note: All voltage values in this data sheet are with respect to V_{SS} unless otherwise specified.

DC ELECTRICAL CHARACTERISTICS (0°C ≤ Ta ≤ 70°C, V_{CC} = 5.0V ±10%)

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SYMBOL	PARAMETER	SPEED	MIN.	MAX.	UNIT	TEST CONDITIONS	NOTES
I_{CC1}	Operating Current	-45 -50 -60 -70		180 160 150 130	mA mA mA mA	t_{RC} = t_{RC} (min.) $\overline{RAS}$, $\overline{CAS}$, Address cycling	1, 2
I_{CC2}	Standby Current			1.0	mA	$\overline{RAS}$ = $\overline{CAS}$ ≥ (V_{CC} - 0.2V)	
				2.0	mA	$\overline{RAS}$ = $\overline{CAS}$ ≥ V_{IH}	
	Standby Current (L version)			100	µA	$\overline{RAS}$ = $\overline{CAS}$ ≥ (V_{CC} - 0.2V) All other inputs are stable at (V_{CC} - 0.2V) or (V_{SS} + 0.2V)	
I_{CC3}	Refresh Current ($\overline{RAS}$ only refresh)	-45 -50 -60 -70		180 160 150 130	mA mA mA mA	t_{RC} = t_{RC} (min.) $\overline{RAS}$ cycling, $\overline{CAS}$ = V_{IH}	1
I_{CC4}	Fast Page Mode Current	-45 -50 -60 -70		100 90 80 70	mA mA mA mA	t_{PC} = t_{PC} (min.) $\overline{RAS}$ = V_{IL} $\overline{CAS}$, Address cycling	1,2
I_{CC5}	Refresh Current ($\overline{CAS}$ before $\overline{RAS}$ refresh)	-45 -50 -60 -70		180 160 150 130	mA mA mA mA	t_{RC} = t_{RC} (min.) $\overline{RAS}$, $\overline{CAS}$ cycling	1
I_{CC6}	Refresh Current (L version : $\overline{CAS}$ before $\overline{RAS}$ refresh)			150	µA	512 cycles / 128ms t_{RAS} ≤ 200ns, $\overline{WE}$ ≥ (V_{CC} - 0.2V) All other inputs are stable at (V_{CC} - 0.2V) or (V_{SS} + 0.2V)	
I_{CC7}	Self Refresh Mode Current (L version)			150	µA	$\overline{RAS}$ =$\overline{CAS}$ ≤ (V_{SS} + 0.2V) All other input high levels are (V_{CC} - 0.2V) or input low levels are (V_{SS} + 0.2V)	
$\|I_{LI}\|$	Input Leakage Current (Any input pin)		-10	10	µA	0V ≤ V_{IH} ≤ 5.5V, Others = 0V	
$\|I_{LO}\|$	Output Leakage Current (For high impedance state)		-10	10	µA	$\overline{RAS}$ ≥ V_{IH}(min.), $\overline{CAS}$ ≥ V_{IH}(min.) 0V ≤ V_{OUT} ≤ 5.5V	
V_{OH}	Output High Voltage		2.4		V	I_{OH} = -5.0 mA	
V_{OL}	Output Low Voltage			0.4	V	I_{OL} = 4.2 mA	

Notes: 1. I_{CC1}, I_{CC3}, I_{CC4} and I_{CC5} depend on cycle rate.
2. I_{CC1} and I_{CC4} depend on output loading. Specified values are obtained with the outputs open.

CAPACITANCE (0°C ≤ Ta ≤ 70°C, V_{CC} = 5.0V ±10%, f = 1MHz)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
C_{IN1}	Address(A0 ~ A8)	—	5	pF
C_{IN2}	$\overline{RAS}$, $\overline{UCAS}$, $\overline{LCAS}$, $\overline{WE}$,$\overline{OE}$	—	5	pF
C_{OUT}	I/O1~I/O16	—	7	pF

DC ELECTRICAL CHARACTERISTICS (0°C ≤ Ta ≤ 70°C, V_{CC} = 5.0V ±10%)
(NN514260A)

SYMBOL	PARAMETER	SPEED	MIN.	MAX.	UNIT	TEST CONDITIONS	NOTES
I_{CC1}	Operating Current	-35		180	mA	t_{RC} = t_{RC} (min.)	1, 2
		-40		160	mA	$\overline{RAS}$, $\overline{CAS}$, Address cycling	
		-45		140	mA		
		-50		120	mA		
		-60		100	mA		
I_{CC2}	Standby Current			1.0	mA	$\overline{RAS}$ = $\overline{CAS}$ ≥ (V_{CC} - 0.2V)	
				2.0	mA	$\overline{RAS}$ = $\overline{CAS}$ ≥ V_{IH}	
	Standby Current (L version)			150	µA	$\overline{RAS}$ = $\overline{CAS}$ ≥ (V_{CC} - 0.2V) All other inputs are stable at (V_{CC} - 0.2V) or (V_{SS} + 0.2V)	
I_{CC3}	Refresh Current ($\overline{RAS}$ only refresh)	-35		180	mA	t_{RC} = t_{RC} (min.)	1
		-40		160	mA	$\overline{RAS}$ cycling, $\overline{CAS}$ = V_{IH}	
		-45		140	mA		
		-50		120	mA		
		-60		100	mA		
I_{CC4}	Fast Page Mode Current	-35		80	mA	t_{PC} = t_{PC} (min.)	1,2
		-40		70	mA	$\overline{RAS}$ = V_{IL}	
		-45		60	mA	$\overline{CAS}$, Address cycling	
		-50		50	mA		
		-60		40	mA		
I_{CC5}	Refresh Current ($\overline{CAS}$ before $\overline{RAS}$ refresh)	-35		180	mA	t_{RC} = t_{RC} (min.)	1
		-40		160	mA	$\overline{RAS}$, $\overline{CAS}$ cycling	
		-45		140	mA		
		-50		120	mA		
		-60		100	mA		
I_{CC6}	Refresh Current (L version : $\overline{CAS}$ before $\overline{RAS}$ refresh)			200	µA	512 cycles / 128ms t_{RAS} ≤ 200ns, $\overline{WE}$ ≥ (V_{CC} - 0.2V) All other inputs are stable at (V_{CC} - 0.2V) or (V_{SS} + 0.2V)	
I_{CC7}	Self Refresh Mode Current (L version)			200	µA	$\overline{RAS}$ =$\overline{CAS}$ ≤ (V_{SS} + 0.2V) All other input high levels are (V_{CC} - 0.2V) or input low levels are (V_{SS} + 0.2V)	
$\|I_{LI}\|$	Input Leakage Current (Any input pin)		-10	10	µA	0V ≤ V_{IH} ≤ 5.5V, Others = 0V	
$\|I_{LO}\|$	Output Leakage Current (For high impedance state)		-10	10	µA	$\overline{RAS}$ ≥ V_{IH}(min.), $\overline{CAS}$ ≥ V_{IH}(min.) 0V ≤ V_{OUT} ≤ 5.5V	
V_{OH}	Output High Voltage		2.4		V	I_{OH} = -5.0 mA	
V_{OL}	Output Low Voltage			0.4	V	I_{OL} = 4.2 mA	

Notes: 1. I_{CC1} , I_{CC3} , I_{CC4} and I_{CC5} depend on cycle rate.
2. I_{CC1} and I_{CC4} depend on output loading. Specified values are obtained with the outputs open.

CAPACITANCE (0°C ≤ Ta ≤ 70°C, V_{CC} = 5.0V ±10%, f = 1MHz)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
C_{IN1}	Address(A0 ~ A8)	—	5	pF
C_{IN2}	$\overline{RAS}$, $\overline{UCAS}$, $\overline{LCAS}$, $\overline{WE}$,$\overline{OE}$	—	5	pF
C_{OUT}	I/O1~I/O16	—	7	pF

AC ELECTRICAL CHARACTERISTICS

Test conditions : V_{IH} / V_{IL} = 2.4V / 0.8V V_{OH} / V_{OL} = 2.0V / 0.8V output loading C_L = 100pF + 2TTL

Operating conditions : (0 °C≤Ta≤70°C, V_{CC} = 5 V ± 10%, V_{SS} = 0 V) (NOTES 3, 4, 5)

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NO.	NOTES		PARAMETER	-45		-50		-60		-70		UNIT	NOTE
	JEDEC	STD.		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
1	t_{CL1QV}	t_{CAC}	Access Time from $\overline{CAS}$	—	15	—	15	—	15	—	20	ns	6,13
2	t_{CH2QV}	t_{CPA}	Access Time from $\overline{CAS}$ Precharge	—	30	—	32	—	35	—	40	ns	13,14
3	t_{AVQV}	t_{AA}	Access Time from Column Address	—	25	—	27	—	30	—	35	ns	7,13
4	t_{RL1QV}	t_{RAC}	Access Time from $\overline{RAS}$	—	45	—	50	—	60	—	70	ns	6,7
5	t_{RL1CH1}	t_{CSH}	$\overline{CAS}$ Hold Time	45	—	50	—	60	—	70	—	ns	
6	t_{RL1CH1}	t_{CHR}	$\overline{CAS}$ Hold Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh)	8	—	8	—	10	—	10	—	ns	
7	t_{RL1CX}	t_{CHS}	$\overline{CAS}$ Precharge Time (Self Refresh Mode)	-50	—	-50	—	-50	—	-50	—	ns	
8	t_{CH2CL2}	t_{CPN}	$\overline{CAS}$ Precharge Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh)	10	—	10	—	10	—	10	—	ns	
9	t_{CH2CL2}	t_{CP}	$\overline{CAS}$ Precharge Time (Fast Page Mode)	5	—	5	—	5	—	5	—	ns	14
10	t_{CL1CH1}	t_{CAS}	$\overline{CAS}$ Pulse Width	13	100K	13	100K	15	100K	20	100K	ns	
11	t_{CL1RL2}	t_{CSR}	$\overline{CAS}$ Setup Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh)	5	—	5	—	5	—	5	—	ns	
12	t_{CL1QX}	t_{CLZ}	$\overline{CAS}$ to Output in Low-Z	0	—	0	—	0	—	0	—	ns	8
13	t_{CH2RL2}	t_{CRP}	$\overline{CAS}$ to $\overline{RAS}$ Precharge Time	5	—	5	—	5	—	5	—	ns	
14	t_{CL1WL2}	t_{CWD}	$\overline{CAS}$ to $\overline{WE}$ Delay Time	35	—	35	—	35	—	50	—	ns	11
15	t_{CL1AX}	t_{CAH}	Column Address Hold Time	8	—	8	—	10	—	15	—	ns	
16	t_{RL1AX}	t_{AR}	Column Address Hold Time Referenced to $\overline{RAS}$	30	—	35	—	40	—	40	—	ns	
17	t_{AVCL2}	t_{ASC}	Column Address Setup Time	0	—	0	—	0	—	0	—	ns	14
18	t_{AVRH1}	t_{RAL}	Column Address to $\overline{RAS}$ Lead Time	22	—	24	—	30	—	35	—	ns	
19	t_{AVWL2}	t_{AWD}	Column Address to $\overline{WE}$ Delay Time	48	—	50	—	50	—	65	—	ns	11
20	t_{CL1DX} t_{WL1DX}	t_{DH}	Data Hold Time	8	—	8	—	10	—	10	—	ns	12
21	t_{DVCL2} t_{DVWL2}	t_{DS}	Data Setup Time	0	—	0	—	0	—	0	—	ns	12
22	t_{OL1QV}	t_{OEA}	$\overline{OE}$ Access Time	—	13	—	15	—	15	—	20	ns	
23	t_{WL1OL2}	t_{OEH}	$\overline{OE}$ Command Hold Time	8	—	8	—	10	—	20	—	ns	
24	t_{CH2QV}	t_{OED}	$\overline{OE}$ to Data Delay Time	7	—	8	—	10	—	10	—	ns	
25	t_{CH2QZ}	t_{OFF}	Output Buffer Turn-off Delay Time	0	13	0	13	0	15	0	20	ns	10
26	t_{OH2QX}	t_{OEZ}	Output Buffer Turn-off Delay Time Referenced to $\overline{OE}$	0	10	0	10	0	15	0	15	ns	
27	t_{CL1RH1}	t_{RSH}	$\overline{RAS}$ Hold Time	13	—	13	—	15	—	20	—	ns	
28	t_{OL1RH1}	t_{ROH}	$\overline{RAS}$ Hold Time Referenced to $\overline{OE}$	8	—	8	—	10	—	10	—	ns	
29	t_{RH2RL2}	t_{RP}	$\overline{RAS}$ Precharge Time	25	—	25	—	30	—	40	—	ns	
30	t_{RH2RL2}	t_{RPS}	$\overline{RAS}$ Precharge Time (Self Refresh Mode)	80	—	90	—	110	—	130	—	ns	
31	t_{RL1RH1}	t_{RAS}	$\overline{RAS}$ Pulse Width	45	100K	50	100K	60	100K	70	100K	ns	
32	t_{RL1RH1}	t_{RASP}	$\overline{RAS}$ Pulse Width (Fast Page Mode)	45	100K	50	100K	60	100K	70	100K	ns	
33	t_{RL1RH1}	t_{RASS}	$\overline{RAS}$ Pulse Width (Self Refresh Mode)	300	—	300	—	300	—	300	—	µs	
34	t_{RL1CL1}	t_{RCD}	$\overline{RAS}$ to $\overline{CAS}$ Delay Time	13	30	13	35	13	45	13	50	ns	6
35	t_{RH2CL2}	t_{RPC}	$\overline{RAS}$ to $\overline{CAS}$ Precharge Time	10	—	10	—	10	—	10	—	ns	

NO.	SYMBOL		PARAMETER	-45		-50		-60		-70		UNIT	NOTE
	JEDEC	STD.		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
36	t_{RL1AV}	t_{RAD}	$\overline{RAS}$ to Column Address Delay Time	11	20	11	23	11	30	11	35	ns	7
37	t_{RL1WL2}	t_{RWD}	$\overline{RAS}$ to $\overline{WE}$ Delay Time	75	—	80	—	85	—	100	—	ns	11
38	t_{CH2WL2}	t_{RCH}	Read Command Hold Time	0	—	0	—	0	—	0	—	ns	9
39	t_{RH2WL2}	t_{RRH}	Read Command Hold Time Referenced to $\overline{RAS}$	5	—	5	—	5	—	5	—	ns	9
40	t_{WH2CL2}	t_{RCS}	Random Command Setup Time	0	—	0	—	0	—	0	—	ns	
41	t_{RL2RL2}	t_{RC}	Random Read or Write Cycle Time	80	—	90	—	110	—	130	—	ns	
42	t_{CL2CL2}	t_{PC}	Read or Write Cycle Time (Fast Page Mode)	30	—	33	—	40	—	45	—	ns	13,14
43	t_{RL2RL2}	t_{RMW}	Read-Modify-Write Cycle Time	120	—	125	—	135	—	185	—	ns	
44	t_{CL2CL2}	t_{PRMW}	Read-Modify-Write Cycle Time (Fast Page Mode)	57	—	57	—	66	—	100	—	ns	13,14
45	t_{REF}	t_{REF}	Refresh Period	—	8	—	8	—	8	—	8	ms	15
46	t_{RL1AX}	t_{RAH}	Row Address Hold Time	8	—	8	—	8	—	8	—	ns	
47	t_{AVRL2}	t_{ASR}	Row Address Setup Time	0	—	0	—	0	—	0	—	ns	
48	t_T	t_T	Transition Time (Rise and Fall)	2	50	2	50	2	50	2	50	ns	4,5
49	t_{CL1WH1}	t_{WCH}	Write Command Hold Time	8	—	8	—	10	—	15	—	ns	
50	t_{WL1WH1}	t_{WP}	Write Command Pulse Width	8	—	8	—	10	—	15	—	ns	
51	t_{WL1CL2}	t_{WCS}	Write Command Setup Time	0	—	0	—	0	—	0	—	ns	11
52	t_{WL1CH1}	t_{CWL}	Write Command to $\overline{CAS}$ Lead Time	13	—	13	—	15	—	20	—	ns	
53	t_{WL1RH1}	t_{RWL}	Write Command to $\overline{RAS}$ Lead Time	13	—	13	—	15	—	20	—	ns	

A.C. ELECTRICAL CHARACTERISTICS

Test conditions : V_{IH} / V_{IL} = 2.4V / 0.8V V_{OH} / V_{OL} = 2.0V / 0.8V ouput loading C_L = 50pF + 1TTL

Operating conditions : (0 °C≤Ta≤70°C, V_{CC} = 5 V ± 10%, V_{SS} = 0 V) (NOTES 3, 4, 5)

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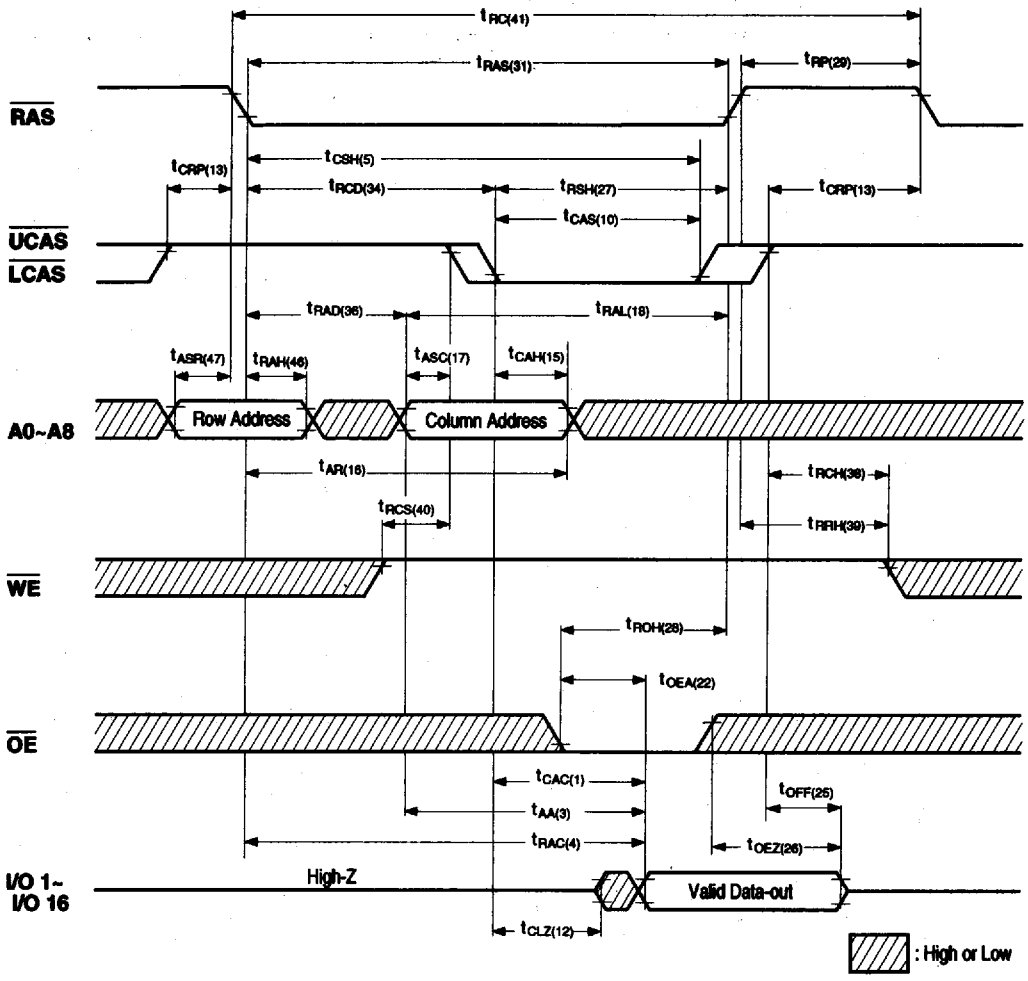
NO.	NOTES		PARAMETER	-35		-40		-45		-50		-60		UNIT	NOTE
	JEDEC	STD.		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
1	t_{CL1QV}	t_{CAC}	Access Time from $\overline{CAS}$	—	10	—	12	—	15	—	15	—	15	ns	6,13
2	t_{CH2QV}	t_{CPA}	Access Time from $\overline{CAS}$ Precharge	—	25	—	28	—	30	—	32	—	35	ns	13,14
3	t_{AVQV}	t_{AA}	Access Time from Column Address	—	17	—	20	—	25	—	27	—	30	ns	7,13
4	t_{RL1QV}	t_{RAC}	Access Time from $\overline{RAS}$	—	35	—	40	—	45	—	50	—	60	ns	6,7
5	t_{RL1CH1}	t_{CSH}	$\overline{CAS}$ Hold Time	35	—	40	—	45	—	50	—	60	—	ns	
6	t_{RL1CH1}	t_{CHR}	$\overline{CAS}$ Hold Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh)	8	—	8	—	8	—	8	—	10	—	ns	
7	t_{RL1CX}	t_{CHS}	$\overline{CAS}$ Precharge Time (Self Refresh Mode)	-50	—	-50	—	-50	—	-50	—	-50	—	ns	
8	t_{CH2CL2}	t_{CPN}	$\overline{CAS}$ Precharge Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh)	10	—	10	—	10	—	10	—	10	—	ns	
9	t_{CH2CL2}	t_{CP}	$\overline{CAS}$ Precharge Time (Fast Page Mode)	5	—	5	—	5	—	5	—	5	—	ns	14
10	t_{CL1CH1}	t_{CAS}	$\overline{CAS}$ Pulse Width	10	100K	12	100K	13	100K	13	100K	15	100K	ns	
11	t_{CL1RL2}	t_{CSR}	$\overline{CAS}$ Setup Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh)	5	—	5	—	5	—	5	—	5	—	ns	
12	t_{CL1QX}	t_{CLZ}	$\overline{CAS}$ to Output in Low-Z	0	—	0	—	0	—	0	—	0	—	ns	8
13	t_{CH2RL2}	t_{CRP}	$\overline{CAS}$ to $\overline{RAS}$ Precharge Time	5	—	5	—	5	—	5	—	5	—	ns	
14	t_{CL1WL2}	t_{CWD}	$\overline{CAS}$ to $\overline{WE}$ Delay Time	30	—	32	—	35	—	35	—	35	—	ns	11
15	t_{CL1AX}	t_{CAH}	Column Address Hold Time	5	—	5	—	8	—	8	—	10	—	ns	
16	t_{RL1AX}	t_{AR}	Column Address Hold Time Referenced to $\overline{RAS}$	25	—	30	—	30	—	35	—	40	—	ns	
17	t_{AVCL2}	t_{ASC}	Column Address Setup Time	0	—	0	—	0	—	0	—	0	—	ns	14
18	t_{AVRH1}	t_{RAL}	Column Address to $\overline{RAS}$ Lead Time	20	—	20	—	22	—	24	—	30	—	ns	
19	t_{AVWL2}	t_{AWD}	Column Address to $\overline{WE}$ Delay Time	35	—	38	—	48	—	50	—	50	—	ns	11
20	t_{CL1DX} t_{WL1DX}	t_{DH}	Data Hold Time	5	—	5	—	8	—	8	—	10	—	ns	12
21	t_{DVCL2} t_{DVWL2}	t_{DS}	Data Setup Time	0	—	0	—	0	—	0	—	0	—	ns	12
22	t_{OL1QV}	t_{OEA}	$\overline{OE}$ Access Time	—	10	—	12	—	13	—	15	—	15	ns	
23	t_{WL1OL2}	t_{OEH}	$\overline{OE}$ Command Hold Time	8	—	8	—	8	—	8	—	10	—	ns	
24	t_{CH2QV}	t_{OED}	$\overline{OE}$ to Data Delay Time	6	—	6	—	7	—	8	—	10	—	ns	
25	t_{CH2QZ}	t_{OFF}	Output Buffer Turn-off Delay Time	0	8	0	10	0	13	0	13	0	15	ns	10
26	t_{OH2QX}	t_{OEZ}	Output Buffer Turn-off Delay Time Referenced to $\overline{OE}$	0	8	0	8	0	10	0	10	0	15	ns	
27	t_{CL1RH1}	t_{RSH}	$\overline{RAS}$ Hold Time	12	—	12	—	13	—	13	—	15	—	ns	
28	t_{OL1RH1}	t_{ROH}	$\overline{RAS}$ Hold Time Referenced to $\overline{OE}$	8	—	8	—	8	—	8	—	10	—	ns	
29	t_{RH2RL2}	t_{RP}	$\overline{RAS}$ Precharge Time	23	—	25	—	25	—	25	—	30	—	ns	
30	t_{RH2RL2}	t_{RPS}	$\overline{RAS}$ Precharge Time (Self Refresh Mode)	60	—	70	—	80	—	90	—	110	—	ns	
31	t_{RL1RH1}	t_{RAS}	$\overline{RAS}$ Pulse Width	35	100K	40	100K	45	100K	50	100K	60	100K	ns	
32	t_{RL1RH1}	t_{RASP}	$\overline{RAS}$ Pulse Width (Fast Page Mode)	35	100K	40	100K	45	100K	50	100K	60	100K	ns	
33	t_{RL1RH1}	t_{RASS}	$\overline{RAS}$ Pulse Width (Self Refresh Mode)	300	—	300	—	300	—	300	—	300	—	µs	
34	t_{RL1CL1}	t_{RCD}	$\overline{RAS}$ to $\overline{CAS}$ Delay Time	10	25	12	28	13	30	13	35	13	45	ns	6

NO.	SYMBOL		PARAMETER	-35		-40		-45		-50		-60		UNIT	NOTE
	JEDEC	STD.		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
35	t_{RH2CL2}	t_{RPC}	$\overline{RAS}$ to $\overline{CAS}$ Precharge Time	10	—	10	—	10	—	10	—	10	—	ns	
36	t_{RL1AV}	t_{RAD}	$\overline{RAS}$ to Column Address Delay Time	9	16	10	19	11	20	11	23	11	30	ns	7
37	t_{RL1WL2}	t_{RWD}	$\overline{RAS}$ to $\overline{WE}$ Delay Time	45	—	58	—	75	—	80	—	85	—	ns	11
38	t_{CH2WL2}	t_{RCH}	Read Command Hold Time	0	—	0	—	0	—	0	—	0	—	ns	9
39	t_{RH2WL2}	t_{RRH}	Read Command Hold Time Referenced to $\overline{RAS}$	5	—	5	—	5	—	5	—	5	—	ns	9
40	t_{WH2CL2}	t_{RCS}	Random Command Setup Time	0	—	0	—	0	—	0	—	0	—	ns	
41	t_{RL2RL2}	t_{RC}	Random Read or Write Cycle Time	60	—	70	—	80	—	90	—	110	—	ns	
42	t_{CL2CL2}	t_{PC}	Read or Write Cycle Time (Fast Page Mode)	20	—	23	—	30	—	33	—	40	—	ns	13,14
43	t_{RL2RL2}	t_{RMW}	Read-Modify-Write Cycle Time	105	—	115	—	120	—	125	—	135	—	ns	
44	t_{CL2CL2}	t_{PRMW}	Read-Modify-Write Cycle Time (Fast Page Mode)	52	—	55	—	57	—	57	—	66	—	ns	13,14
45	t_{REF}	t_{REF}	Refresh Period	—	8	—	8	—	8	—	8	—	8	ms	15
46	t_{RL1AX}	t_{RAH}	Row Address Hold Time	7	—	7	—	8	—	8	—	8	—	ns	
47	t_{AVRL2}	t_{ASR}	Row Address Setup Time	0	—	0	—	0	—	0	—	0	—	ns	
48	t_T	t_T	Transition Time (Rise and Fall)	2	50	2	50	2	50	2	50	2	50	ns	4,5
49	t_{CL1WH1}	t_{WCH}	Write Command Hold Time	5	—	5	—	8	—	8	—	10	—	ns	
50	t_{WL1WH1}	t_{WP}	Write Command Pulse Width	5	—	5	—	8	—	8	—	10	—	ns	
51	t_{WL1CL2}	t_{WCS}	Write Command Setup Time	0	—	0	—	0	—	0	—	0	—	ns	11
52	t_{WL1CH1}	t_{CWL}	Write Command to $\overline{CAS}$ Lead Time	12	—	12	—	13	—	13	—	15	—	ns	
53	t_{WL1RH1}	t_{RWL}	Write Command to $\overline{RAS}$ Lead Time	12	—	12	—	13	—	13	—	15	—	ns	

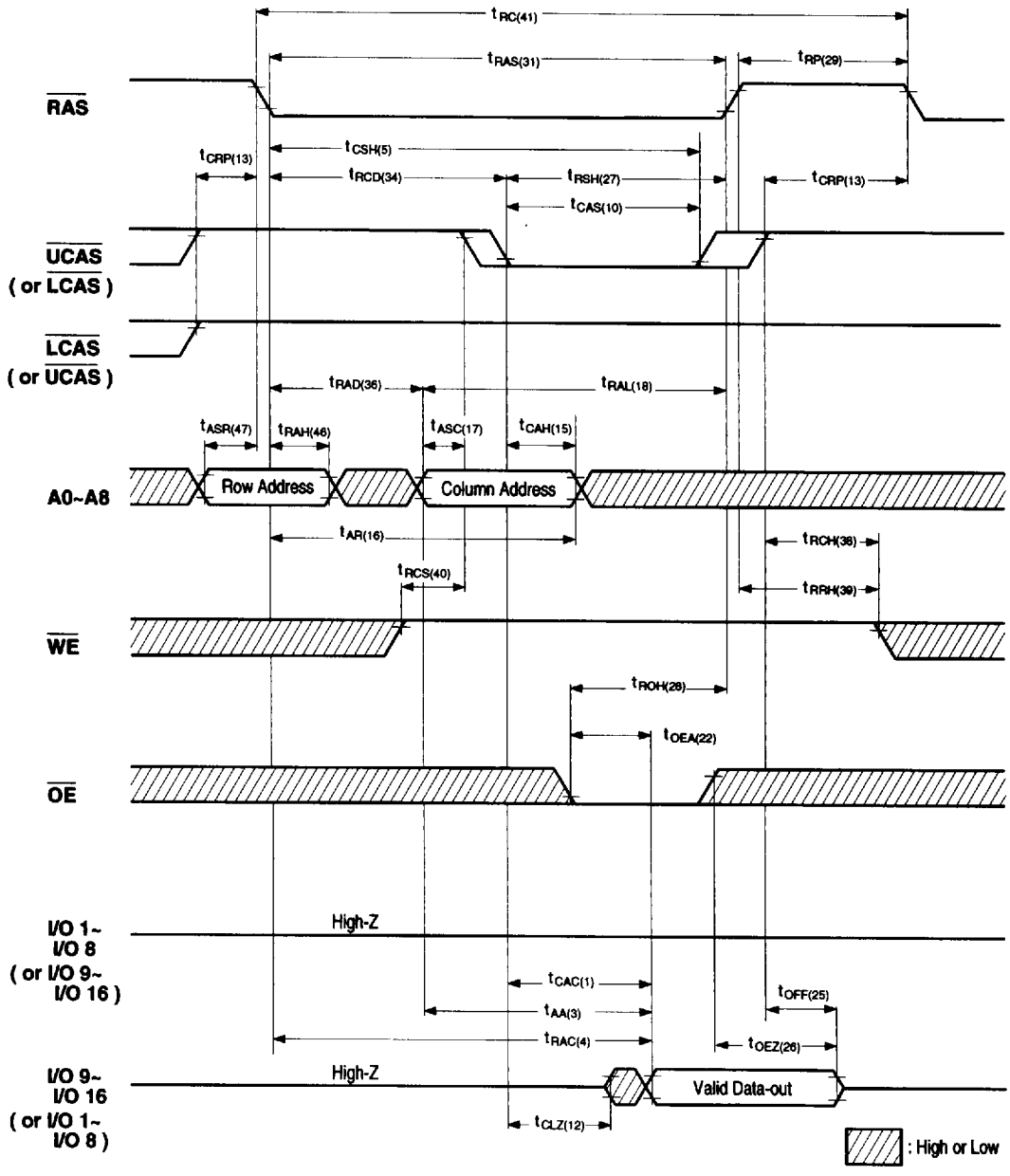
Notes: (NN514260/A/B)

3. Eight Initialization Cycles are required following a 200μs pause after Power Up. These Initialization Cycles may consist of any combination of the following : $\overline{RAS}$ only refresh Cycles, Read Cycles, Write Cycles, $\overline{CAS}$ before $\overline{RAS}$ refresh Cycles.
4. AC measurements assume t_T=3ns.
5. V_{IH}(min.) and V_{IL}(max.) are reference levels for measuring timing of input signals. Also, transition times are measured between V_{IH} and V_{IL}.
6. Operation within the t_{RCD}(max.) limit ensures that t_{RAC}(max.) can be met. t_{RCD}(max.) is specified as a reference point only. If t_{RCD} is greater than the specified t_{RCD}(max.) limit, then access time is controlled by t_{CAC}.
7. Operation within the t_{RAD}(max.) limit ensures that t_{RAC}(max.) can be met. t_{RAD}(max.) is specified as a reference point only. If t_{RAD} is greater than the specified t_{RAD}(max.) limit, then access time is controlled by t_{AA}.
8. Assumes three state test load (5pF and a 220 ohm to 1.3V Thevenin equivalent).
9. Either t_{RCH} or t_{RRH} must be satisfied for a read cycle.
10. t_{OFF}(max.) defines the time at which the output achieves an open circuit condition and is not referenced to output voltage levels.
11. t_{WCS}, t_{RWD}, t_{CWD} and t_{AWD} are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only. If $t_{WCS} \geq t_{WCS}$(min.) , the cycle is an early write cycle and data-out pins will remain open circuit (high impedance) throughout the entire cycle. If $t_{RWD} \geq t_{RWD}$(min.), $t_{CWD} \geq t_{CWD}$(min.) and $t_{AWD} \geq t_{AWD}$(min.), the cycle is a read-modify-write cycle and the data-out will contain data read from the selected cell. If neither of the above conditions is satisfied, the condition of the data-out (at access time) is indeterminate.
12. These parameters are referenced to $\overline{CAS}$ leading edge in early write cycles and to $\overline{WE}$ leading edge in read-modify-write cycles.
13. Access time is determined by the longer of t_{AA}, t_{CAC}, or t_{CPA}.
14. $t_{ASC} \geq t_{CP}$ to achieve t_{PC}(min.) and t_{CPA}(max.) values.
15. t_{REF}=128msec for Long Refresh version (L version).

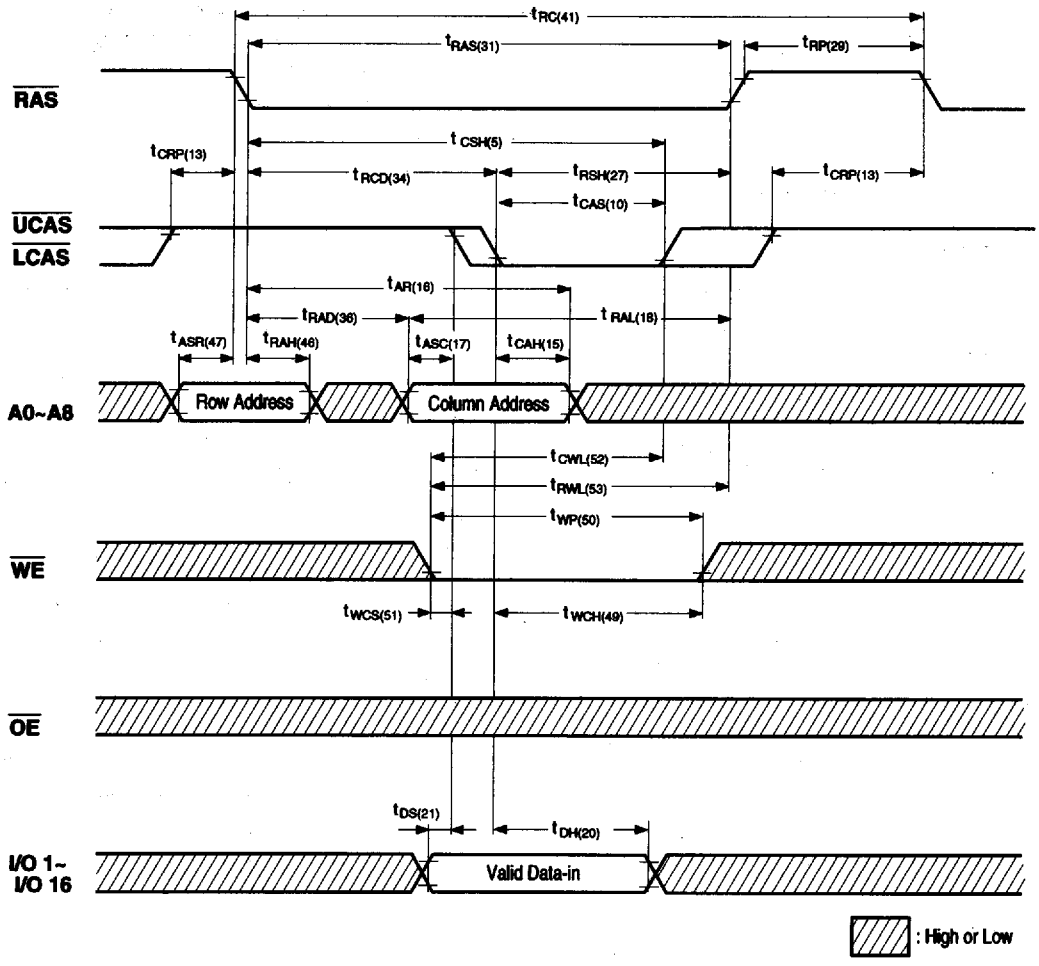
WORD READ CYCLE



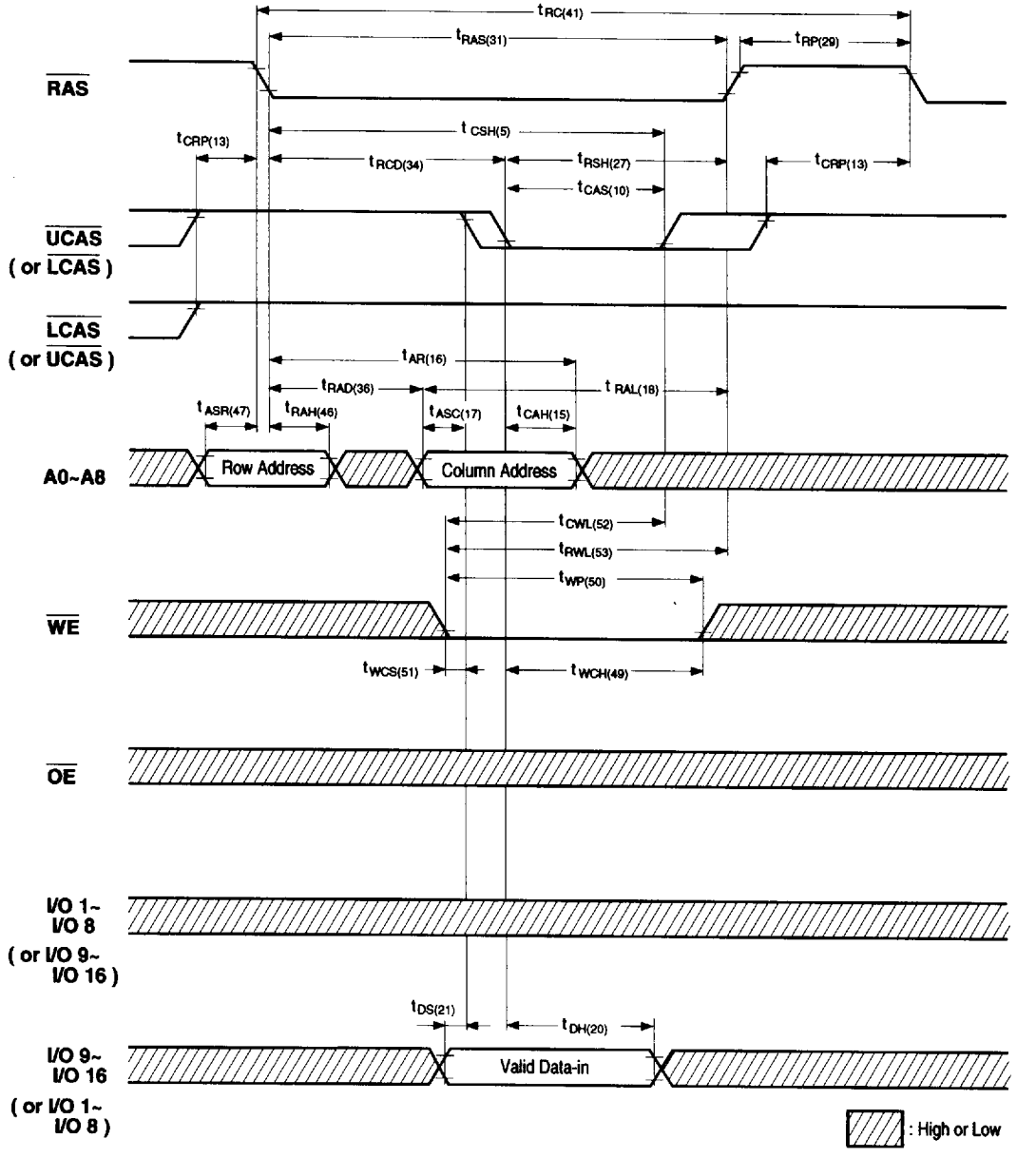
BYTE READ CYCLE



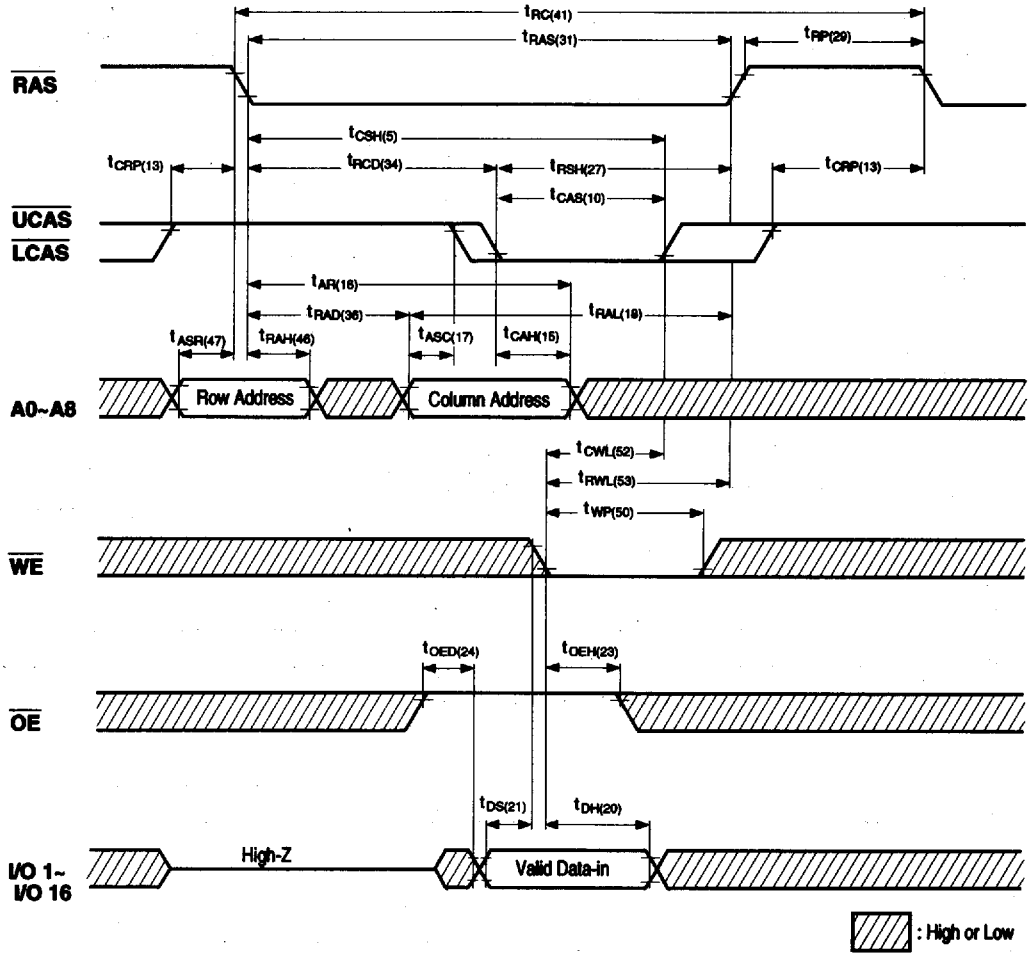
WORD WRITE CYCLE (EARLY WRITE)



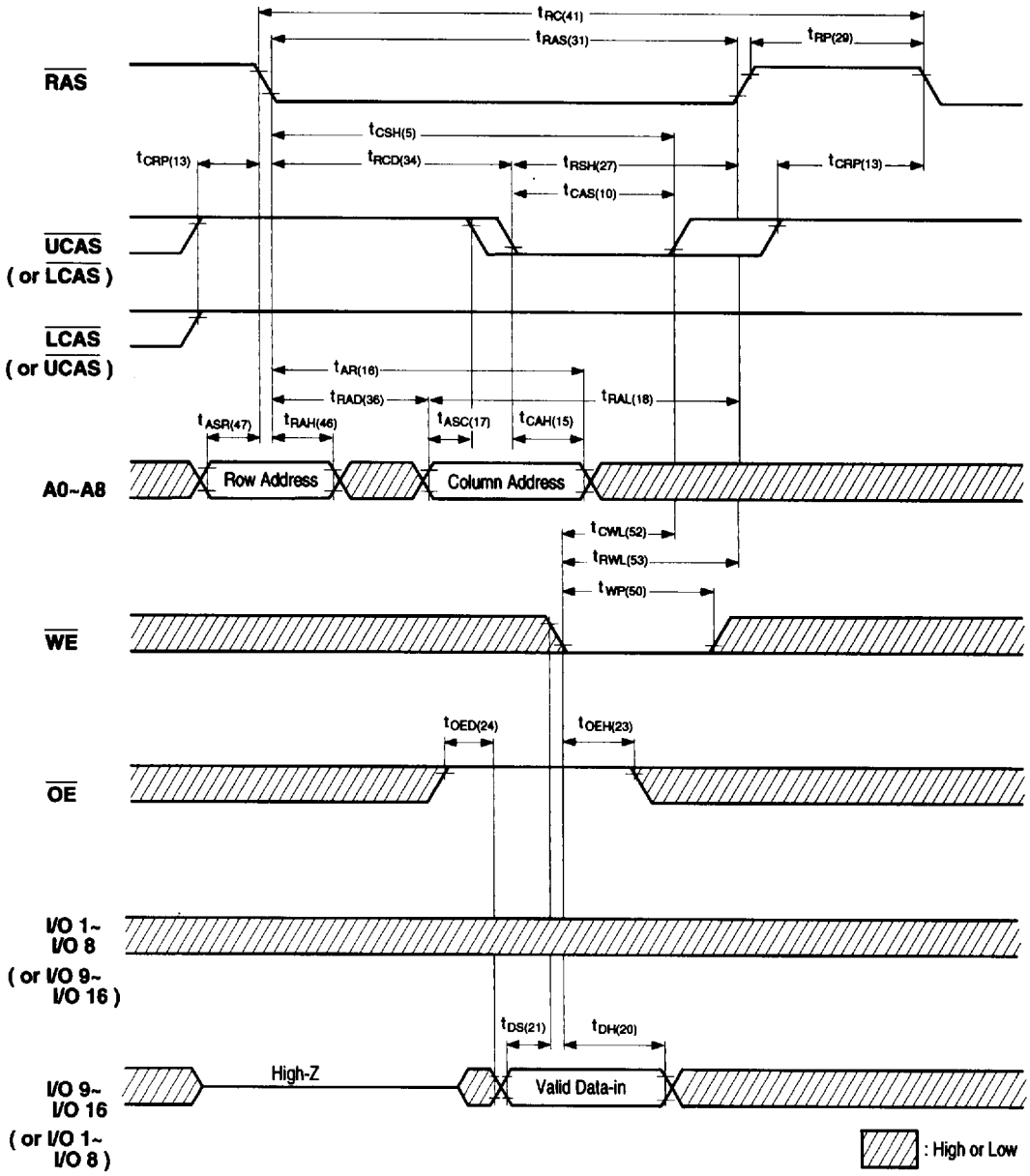
BYTE WRITE CYCLE (EARLY WRITE)



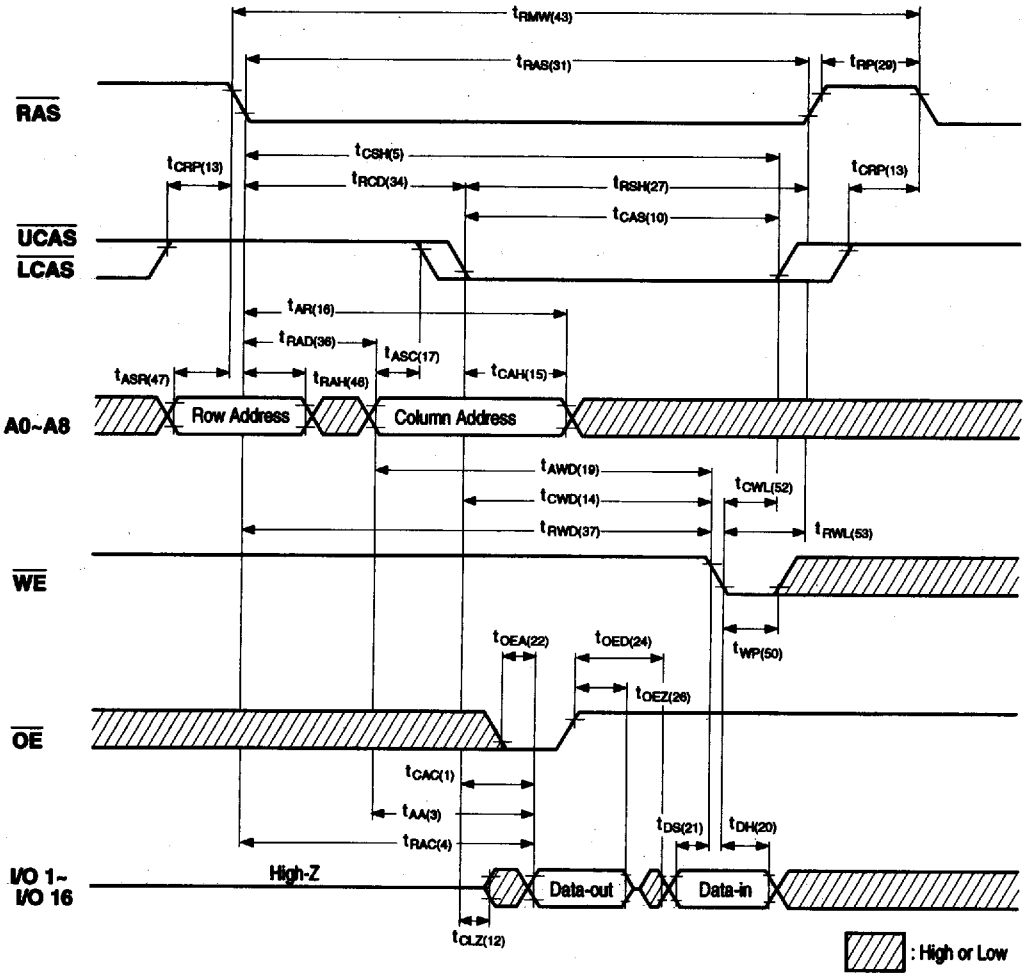
WORD WRITE CYCLE ($\overline{OE}$-CONTROLLED WRITE)



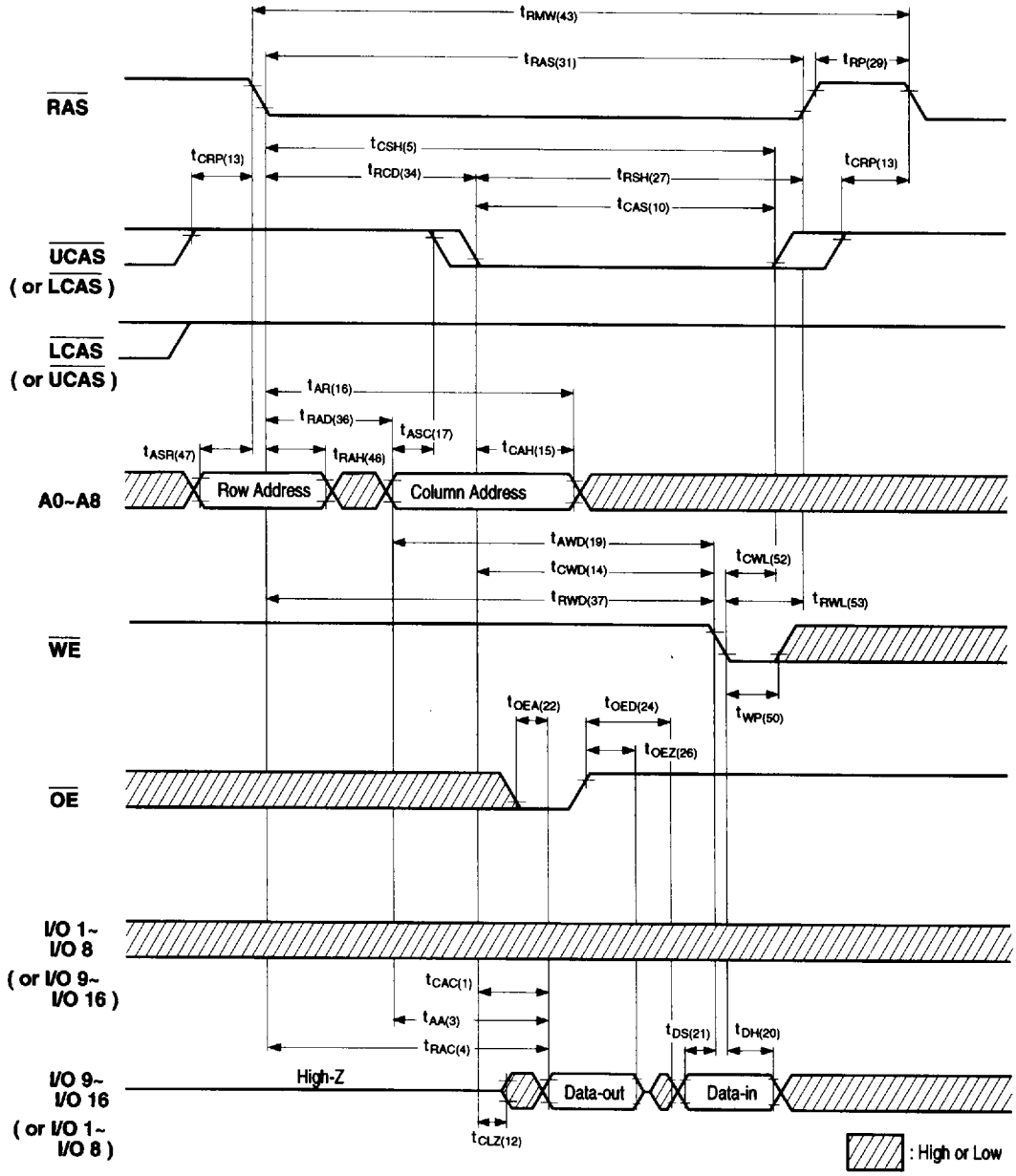
BYTE WRITE CYCLE (OE-CONTROLLED WRITE)



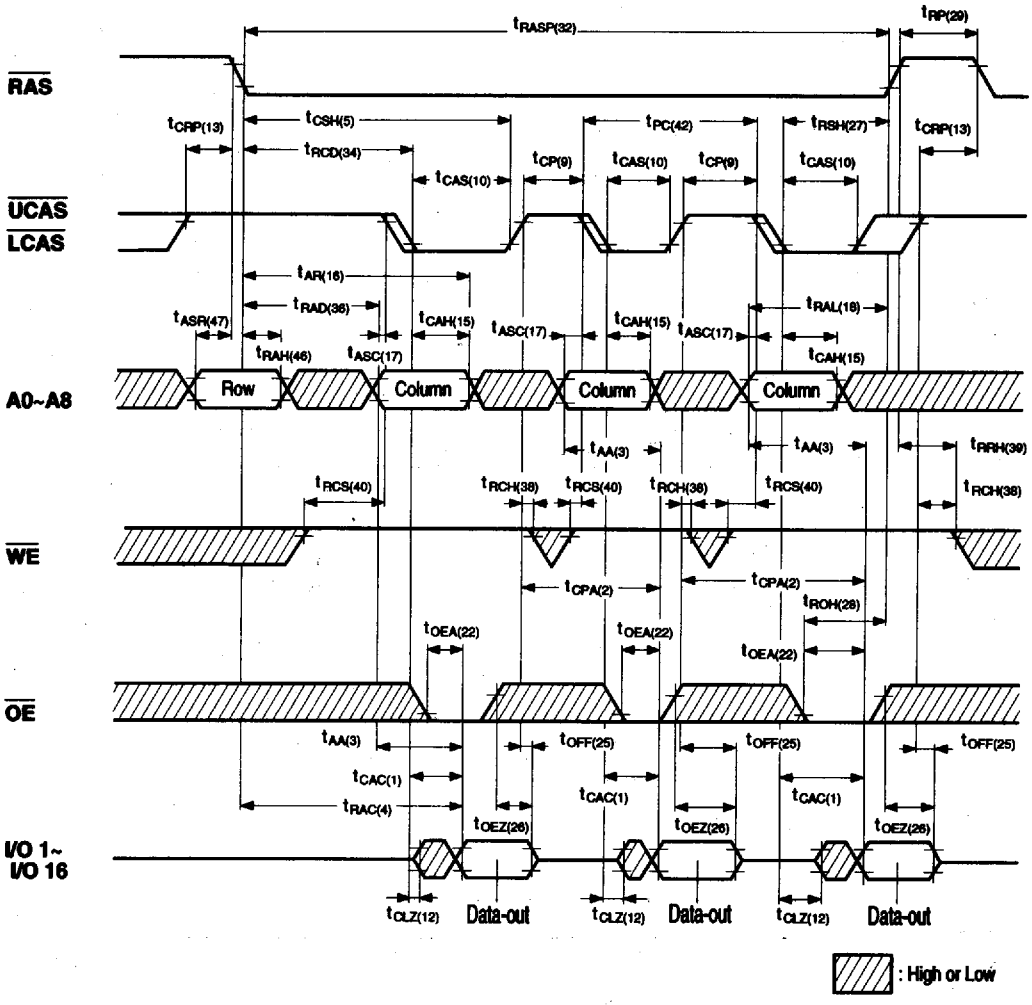
WORD READ-MODIFY-WRITE CYCLE



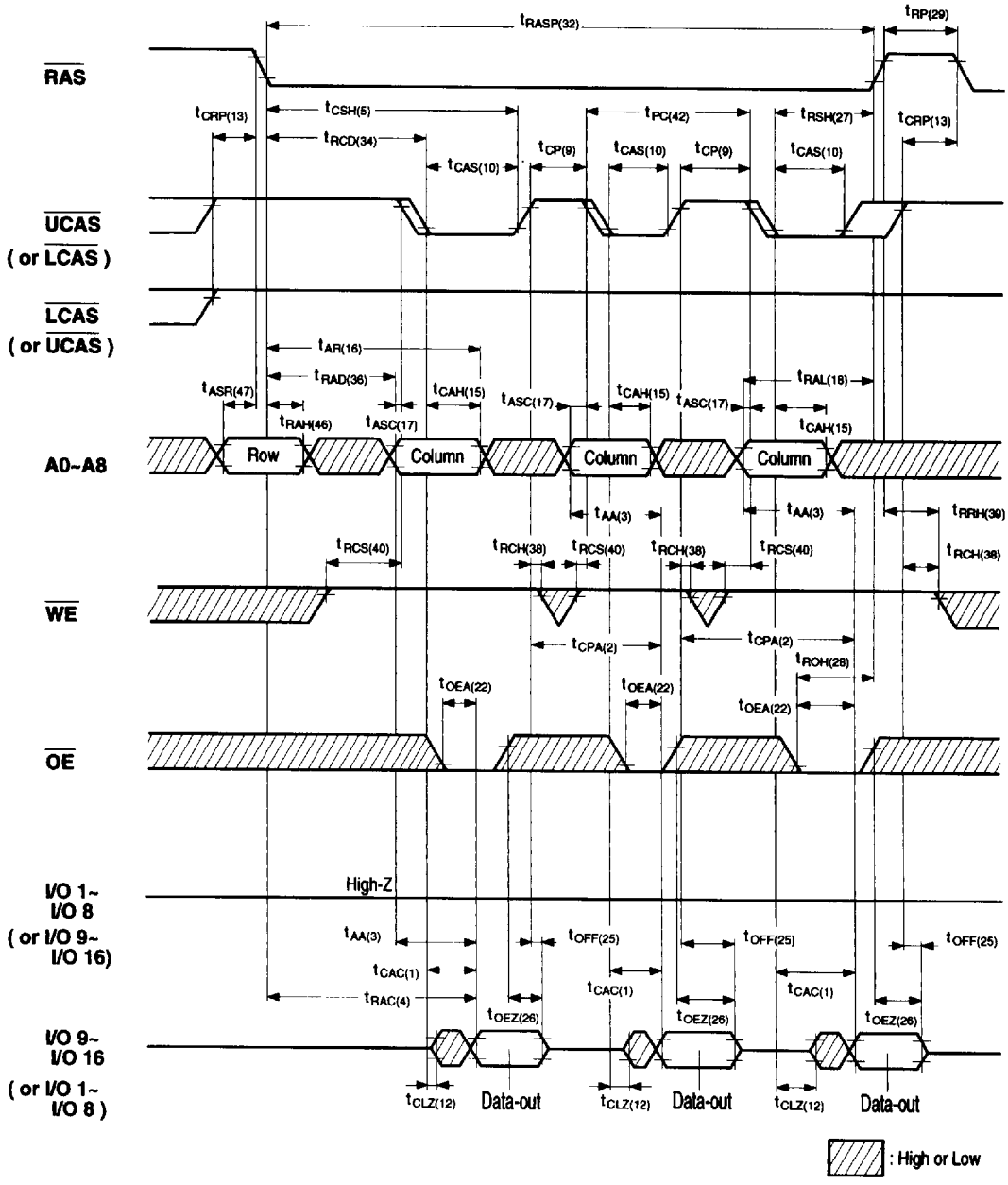
BYTE READ-MODIFY-WRITE CYCLE



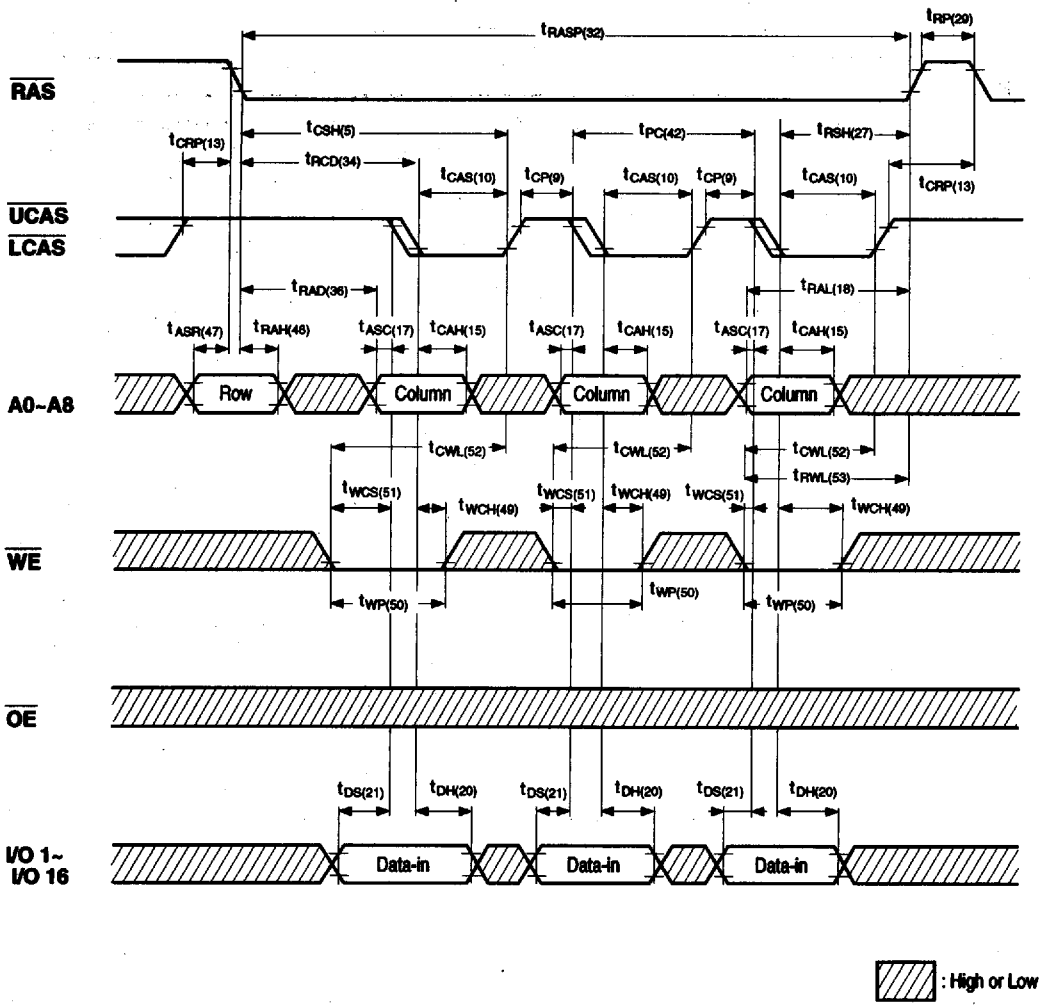
FAST PAGE MODE WORD READ CYCLE



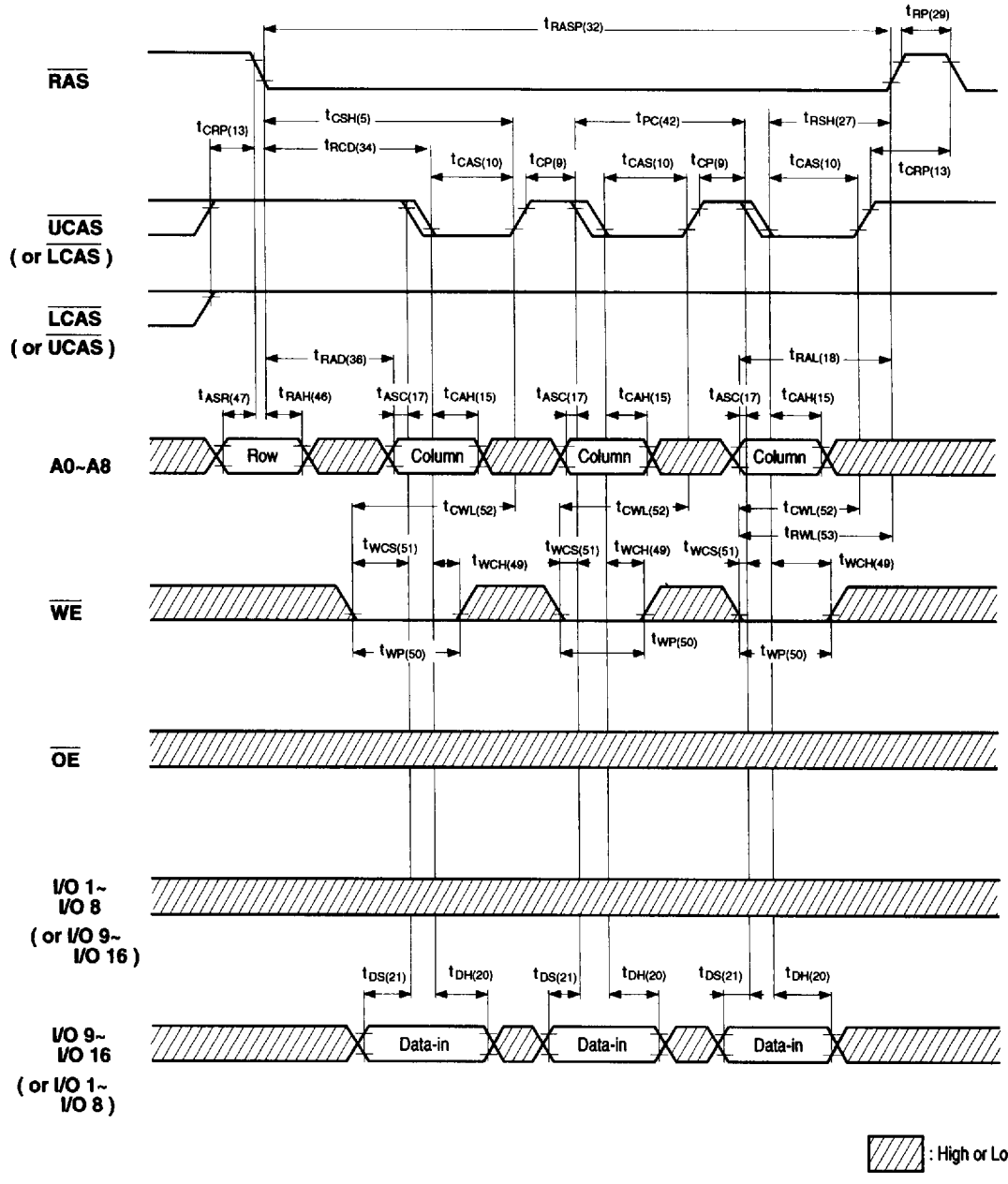
FAST PAGE MODE BYTE READ CYCLE



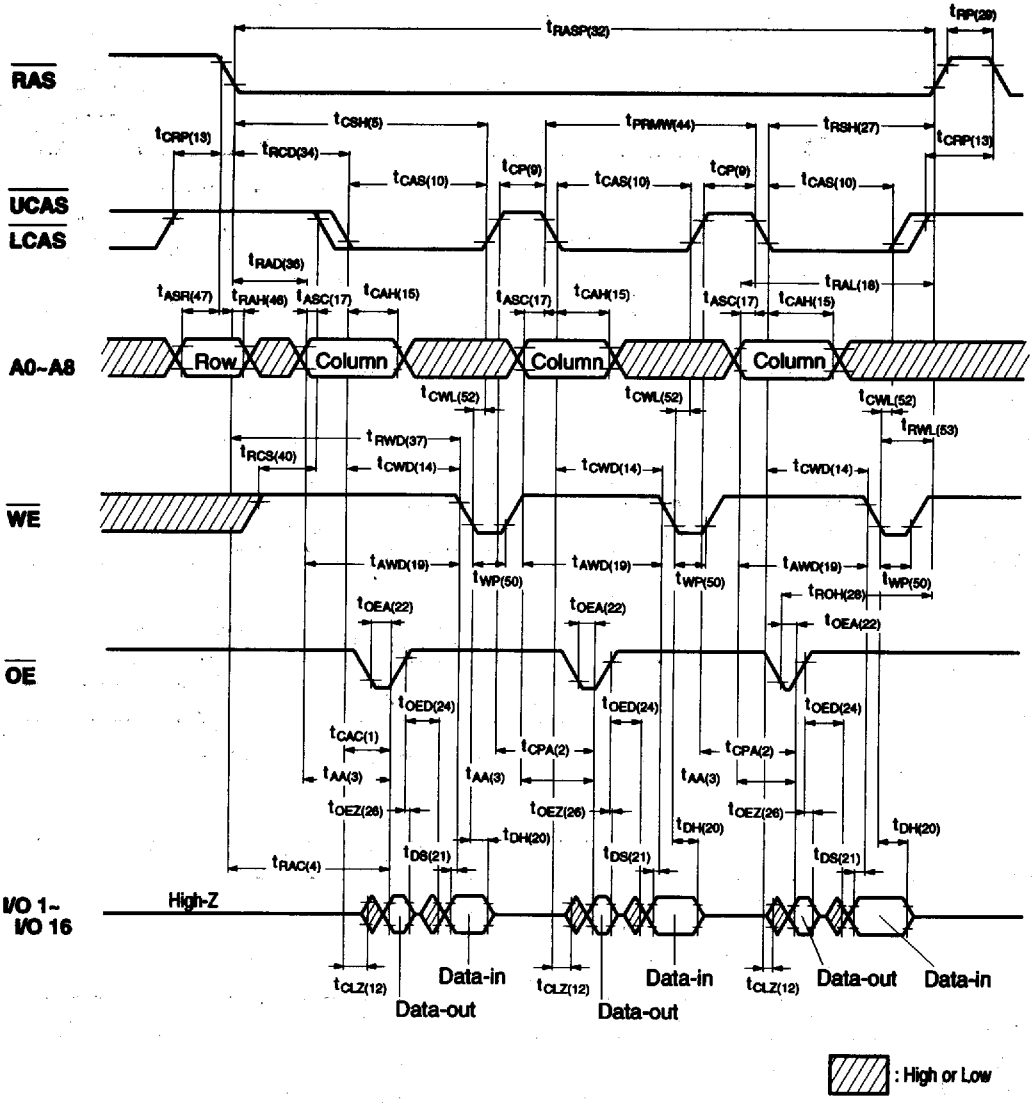
FAST PAGE MODE EARLY WORD WRITE CYCLE



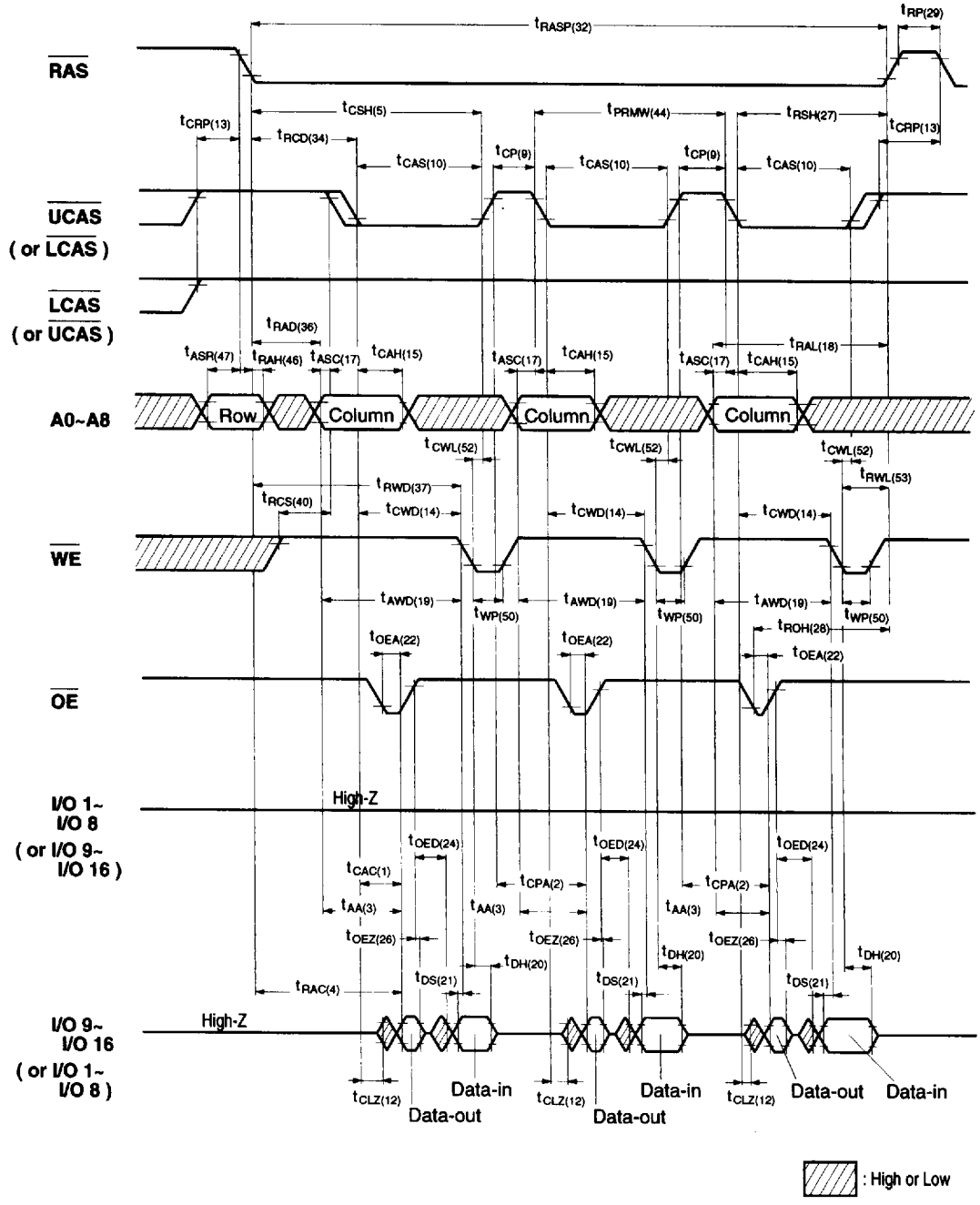
FAST PAGE MODE EARLY BYTE WRITE CYCLE



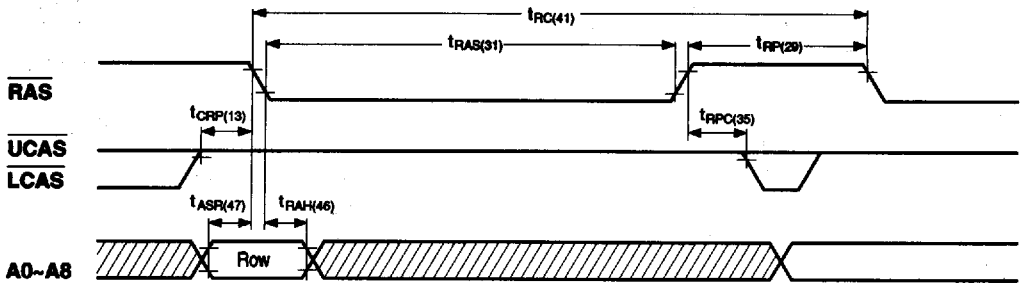
FAST PAGE MODE WORD READ-MODIFY-WRITE CYCLE



FAST PAGE MODE BYTE READ-MODIFY-WRITE CYCLE



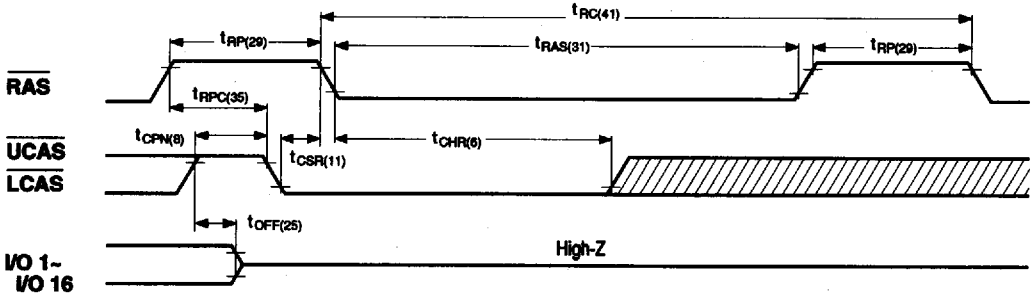
$\overline{RAS}$ ONLY REFRESH CYCLE



Note: $\overline{WE}$, $\overline{OE}$ = Don't care.

: High or Low

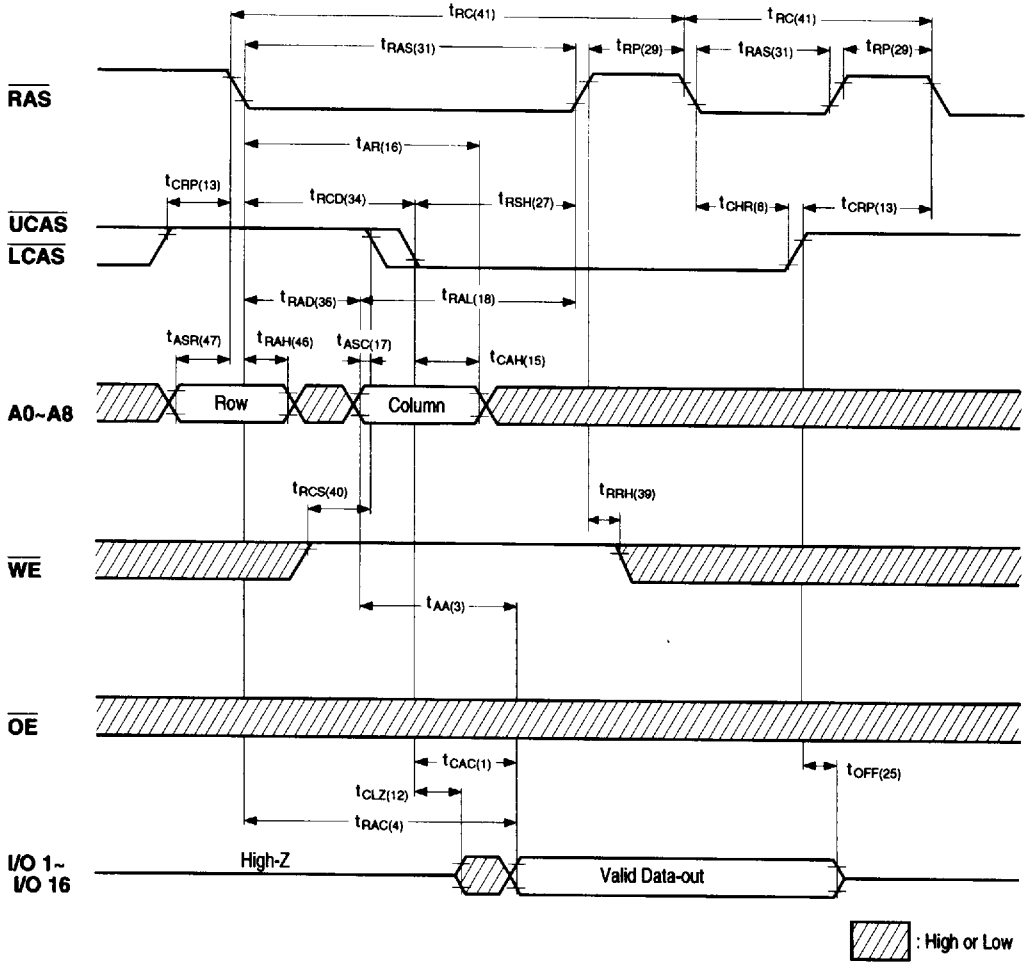
$\overline{CAS}$ BEFORE $\overline{RAS}$ REFRESH CYCLE



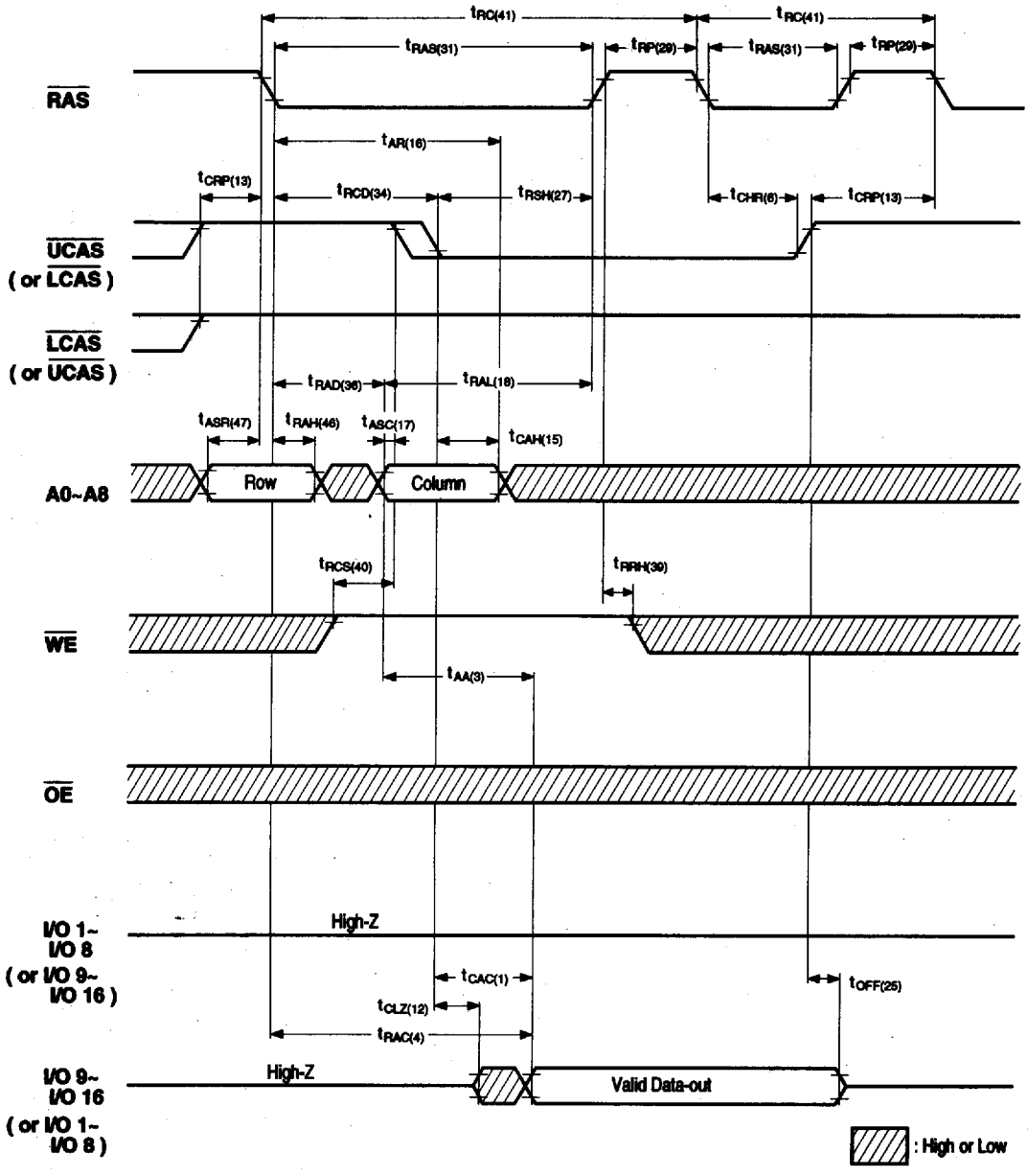
: High or Low

Note: $\overline{WE}$, $\overline{OE}$, A0~A8 = Don't care.

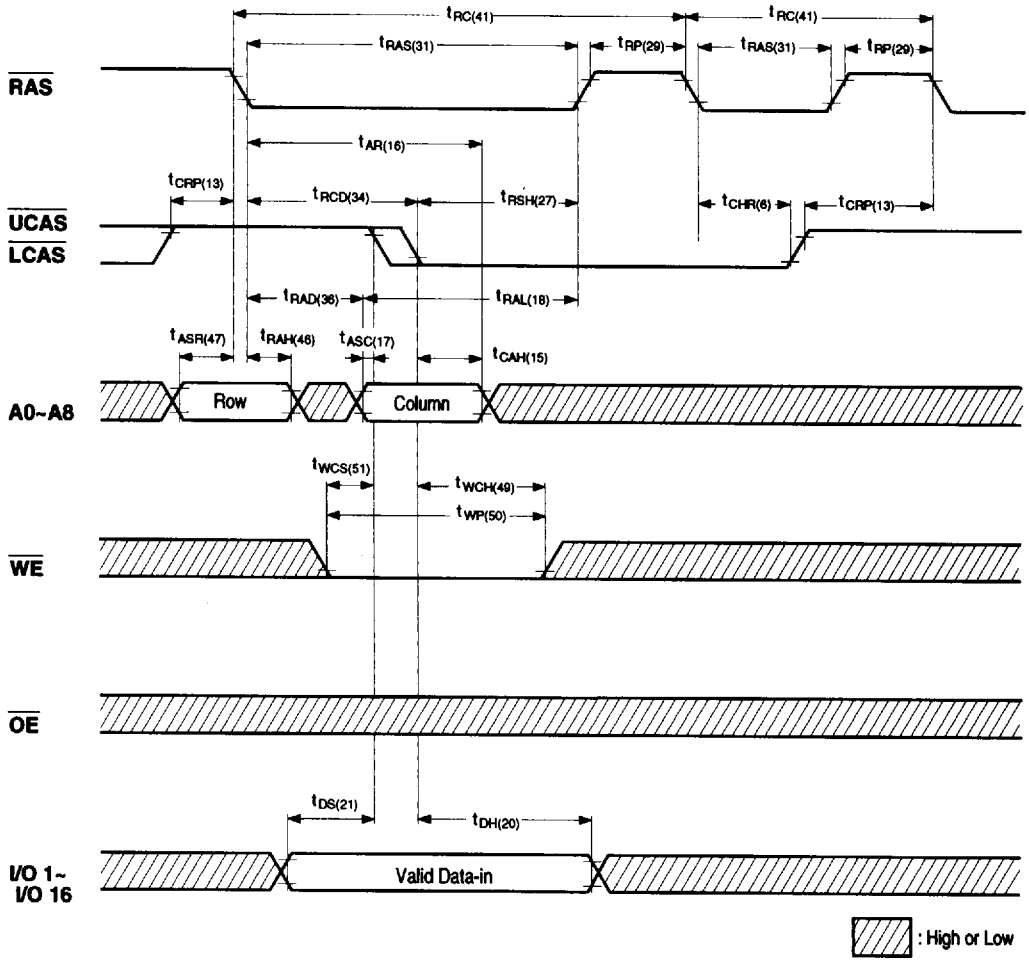
HIDDEN REFRESH CYCLE (WORD READ)



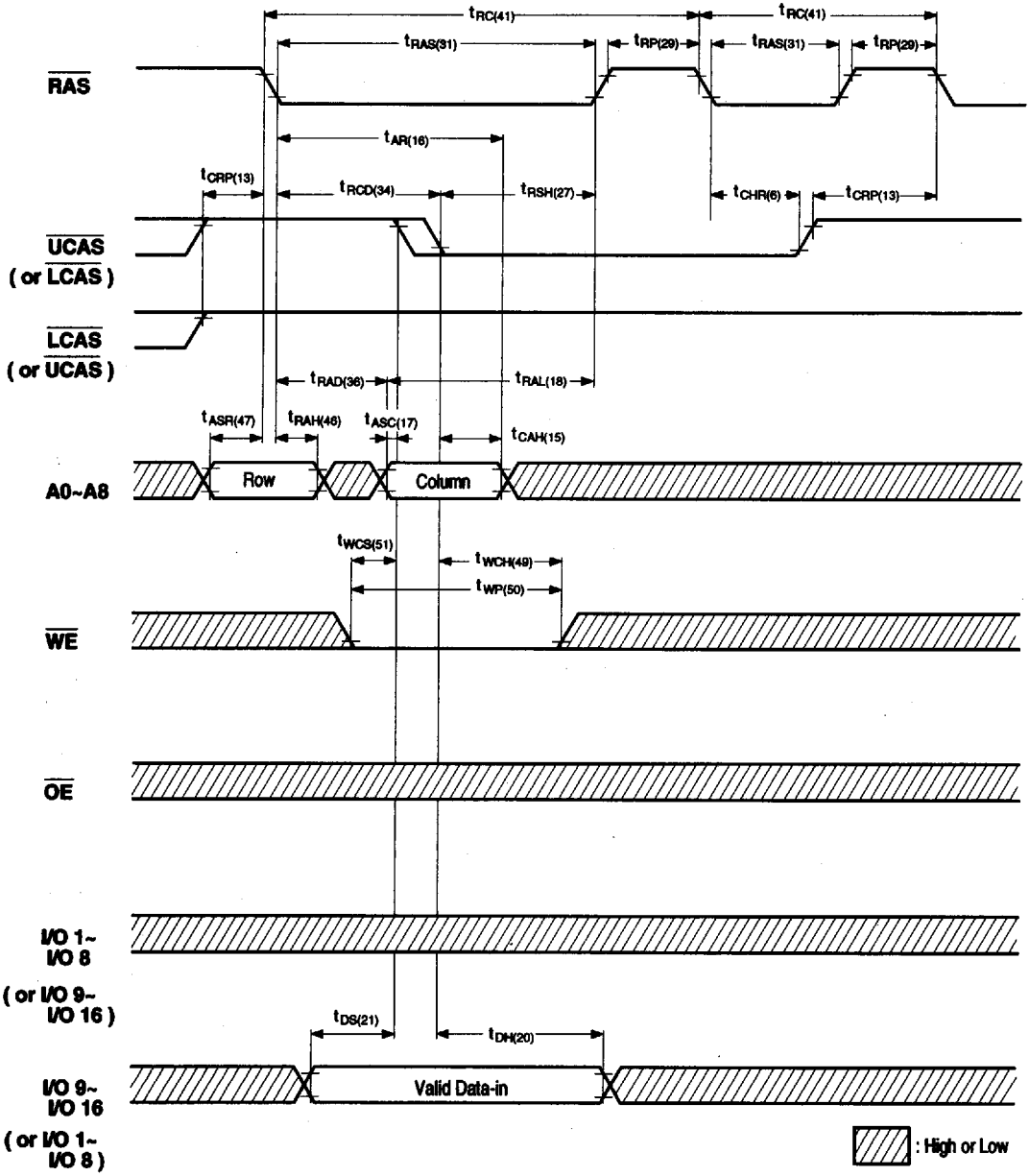
HIDDEN REFRESH CYCLE (BYTE READ)



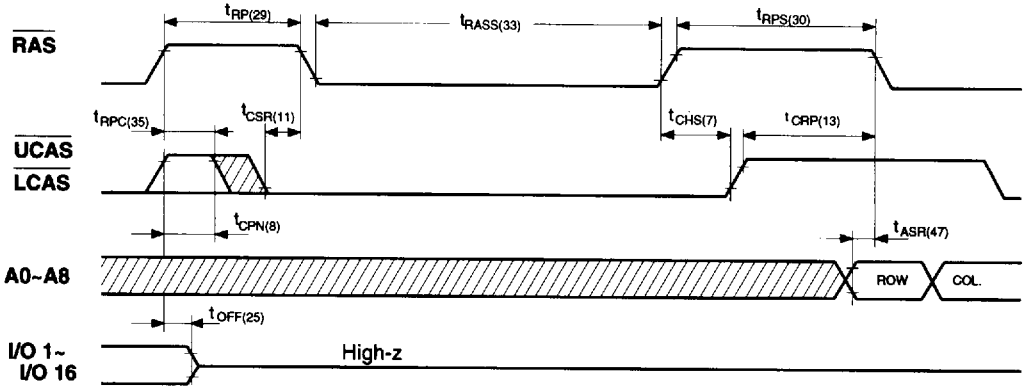
HIDDEN REFRESH CYCLE (EARLY WORD WRITE)



HIDDEN REFRESH CYCLE (EARLY BYTE WRITE)



SELF REFRESH MODE



Note: $\overline{WE}$, $\overline{OE}$ = Don't care.

▨ : High or Low

■ The NN514260L/AL version has a Self Refresh Mode.

a. Entering the Self Refresh Mode:
The NN514260L/ALSelf Refresh Mode is entered by using $\overline{CAS}$ before $\overline{RAS}$ cycle and holding $\overline{RAS}$ and $\overline{CAS}$ signal " low " longer than 300µs.

b. Continuing the Self Refresh Mode:
The Self Refresh Mode is continued by holding $\overline{RAS}$ " low " after entering the Self Refresh Mode.
It does not depend on $\overline{CAS}$ being " high " or " low " after entering the Self Refresh Mode to continue the Self Refresh Mode.

c. Exiting the Self Refresh Mode:
The NN514260L/AL exits the Self Refresh Mode when the $\overline{RAS}$ signal is brought " high ".

ORDERING INFORMATION

NN514260XX(X) - XX

SPEED	45	:	45ns
	50	:	50ns
	60	:	60ns
	70	:	70ns
PACKAGE	J	:	Plastic SOJ
	TT	:	Plastic TSOP TYPEII
VERSION	BLANK	:	Standard Version
	L	:	Long Refresh Version 128ms Refresh
MODE	4260	:	Fast Page 2$\overline{CAS}$,256K x 16 ,512refresh cycle

NN514260AXX(X) - XX

SPEED	35	:	35ns
	40	:	40ns
	45	:	45ns
	50	:	50ns
	60	:	60ns
PACKAGE	J	:	Plastic SOJ
	TT	:	Plastic TSOP TYPEII
VERSION	BLANK	:	Standard Version
	L	:	Long Refresh Version 128ms Refresh
DESIGN CODE	A	:	NN514260A
MODE	4260	:	Fast Page 2$\overline{CAS}$,256K x 16 ,512refresh cycle